CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08

## Features

- True dual-ported memory cells which allow simultaneous access of the same memory location
- 4/8/16K $\times 16$ and $8 / 16 \mathrm{~K} \times 8$ organization
- High-speed access: 35 ns
- Ultra Low operating power
- Active: $I_{C C}=15 \mathrm{~mA}$ (typical) at 55 ns
- Active: $\mathrm{I}_{\mathrm{CC}}=25 \mathrm{~mA}$ (typical) at 35 ns
- Standby: $I_{\text {SB3 }}=2 \mu \mathrm{~A}$ (typical)
- Small footprint: Available in a $6 \times 6 \mathrm{~mm} 100$-pin Lead(Pb)-free fBGA
- Supports 1.8 V , 2.5 V , and 3.0 V I/Os
- Full asynchronous operation
- Automatic power-down
- Pin select for Master or Slave
- Expandable data bus to 32 bits with Master/Slave chip select when using more than one device
- On-chip arbitration logic
- Semaphores included to permit software handshaking between ports
- Input Read Registers and Output Drive Registers
- INT flag for port-to-port communication
- Separate upper-byte and lower-byte control
- Industrial temperature ranges

Selection Guide for 1.8 V

|  | CYDM256A16, CYDM128A16, <br> CYDM064A16, CYDM128A08, <br> CYDM064A08 <br> -35 | CYDM256A16, CYDM128A16, <br> CYDM064A16, CYDM128A08, <br> CYDM064A08 <br> -55 |  |
| :--- | :---: | :---: | :---: |
| Maximum Access Time | 35 | 55 | Unit |
| Typical Operating Current | 25 | 15 | ns |
| Typical Standby Current for I ${ }_{\text {SB1 }}$ | 2 | 2 | mA |
| Typical Standby Current for ISB3 | 2 | 2 | $\mu \mathrm{~A}$ |

Selection Guide for 2.5V

|  | CYDM256A16, CYDM128A16, <br> CYDM064A16, CYDM128A08, <br> CYDM064A08 <br> -35 | CYDM256A16, CYDM128A16, <br> CYDM064A16, CYDM128A08, <br> CYDM064A08 <br> -55 |  |
| :--- | :---: | :---: | :---: |
| Maximum Access Time | 35 | 55 | Unit |
| Typical Operating Current | 39 | 28 | ns |
| Typical Standby Current for ISB1 | 6 | 6 | mA |
| Typical Standby Current for I ISB3 | 4 | 4 | $\mu \mathrm{~A}$ |

## Selection Guide for 3.0V

|  | CYDM256A16, CYDM128A16, <br> CYDM064A16, CYDM128A08, <br> CYDM064A08 <br> -35 | CYDM256A16, CYDM128A16, <br> CYDM064A16, CYDM128A08, <br> CYDM064A08 <br> -55 |  |
| :--- | :---: | :---: | :---: |
| Maximum Access Time | 35 | 55 | Unit |
| Typical Operating Current | 49 | 42 | ns |
| Typical Standby Current for I $\mathrm{I}_{\text {SB1 }}$ | 7 | 7 | mA |
| Typical Standby Current for ISB3 | 6 | 6 | $\mu \mathrm{~A}$ |



Figure 1. Top Level Block Diagram ${ }^{[1,2]}$

## Notes:

1. $A_{0}-A_{11}$ for $4 K$ devices; $A_{0}-A_{12}$ for $8 K$ devices; $A_{0}-A_{13}$ for 16 K devices.
2. BUSY is an output in master mode and an input in slave mode.

# CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, 

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Pin Configurations ${ }^{[3,4,5,6,7,8]}$

## 100-Ball 0.5-mm Pitch BGA <br> Top View <br> CYDM064A16/CYDM128A16/CYDM256A16

|  | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| A | $\mathrm{A}_{5 \mathrm{R}}$ | $\mathrm{A}_{8 \mathrm{R}}$ | $\mathrm{A}_{11 \mathrm{R}}$ | $\overline{U B}_{R}$ | $\mathrm{V}_{\text {SS }}$ | $\overline{S E M}_{R}$ | $\mathrm{l} / \mathrm{O}_{15 \mathrm{R}}$ | $1 / O_{12 R}$ | $1 / \mathrm{O}_{10 \mathrm{R}}$ | $\mathrm{V}_{\mathrm{ss}}$ | A |
| B | $\mathrm{A}_{3 \mathrm{R}}$ | $\mathrm{A}_{4 \mathrm{R}}$ | $\mathrm{A}_{7 \mathrm{R}}$ | $\mathrm{A}_{9 R}$ | $\overline{\mathrm{CE}}_{\mathrm{R}}$ | $\mathrm{R} / \bar{W}_{\mathrm{R}}$ | $\overline{\mathrm{OE}}_{\mathrm{R}}$ | $\mathrm{V}_{\mathrm{cc}}$ | $1 / O_{9 R}$ | $\mathrm{I} / \mathrm{O}_{6 \mathrm{R}}$ | B |
| C | $\mathrm{A}_{\text {OR }}$ | $\mathrm{A}_{1 \mathrm{R}}$ | $\mathrm{A}_{2 \mathrm{R}}$ | $\mathrm{A}_{6 \mathrm{R}}$ | $\overline{L B}_{R}$ | IRR $1^{[6]}$ | $\mathrm{I} / \mathrm{O}_{14 \mathrm{R}}$ | $1 / O_{11 R}$ | $\mathrm{I} / \mathrm{O}_{7 \mathrm{R}}$ | $\mathrm{V}_{\text {ss }}$ | C |
| D | ODR4 | ODR2 | $\overline{B U S Y}_{\text {R }}$ | $\overline{N T}_{R}$ | $\mathrm{A}_{10 \mathrm{R}}$ | $\mathrm{A}_{12 \mathrm{R}}{ }^{[3]}$ | I/ $\mathrm{O}_{13 \mathrm{R}}$ | $\mathrm{I} / \mathrm{O}_{8 \mathrm{R}}$ | $1 / O_{5 R}$ | $\mathrm{I} / \mathrm{O}_{2 R}$ | D |
| E | $\mathrm{V}_{\mathrm{ss}}$ | M/S | ODR3 | $\overline{\mathrm{INT}_{L}}$ | $\mathrm{V}_{\text {SS }}$ | $\mathrm{V}_{\text {Ss }}$ | $\mathrm{I} / \mathrm{O}_{4 \mathrm{R}}$ | $\mathrm{V}_{\mathrm{cc}}$ | $1 / O_{1 R}$ | $\mathrm{V}_{\text {Ss }}$ | E |
| F | $\overline{\text { SFEN }}{ }^{[8]}$ | ODR1 | $\overline{B U S Y}_{L}$ | $\mathrm{A}_{12}$ | $\mathrm{V}_{\mathrm{Cc}}$ | $\mathrm{V}_{\mathrm{ss}}$ | $\mathrm{I} / \mathrm{O}_{3 \mathrm{R}}$ | $\mathrm{I} / \mathrm{O}_{0 \mathrm{R}}$ | $1 / O_{15 L}$ | $\mathrm{V}_{\mathrm{CC}}$ | F |
| G | ODR0 | $\mathrm{A}_{2}$ | $\mathrm{A}_{5 L}$ | $\mathrm{A}_{12 \mathrm{~L}}{ }^{[3]}$ | $\overline{\mathrm{OE}}_{\mathrm{L}}$ | $\mathrm{l} / \mathrm{O}_{3 \mathrm{~L}}$ | $\mathrm{I} / \mathrm{O}_{11 \mathrm{~L}}$ | $\mathrm{l} / \mathrm{O}_{12 \mathrm{~L}}$ | $1 / O_{14 L}$ | $1 / \mathrm{O}_{13 \mathrm{~L}}$ | G |
| H | $\mathrm{A}_{0}$ | $\mathrm{A}_{4 \mathrm{~L}}$ | Ag | $\overline{L B}_{L}$ | $\overline{\mathrm{CE}} \mathrm{L}^{\prime}$ | $\mathrm{I} / \mathrm{O}_{1 \mathrm{~L}}$ | $\mathrm{V}_{\mathrm{cc}}$ | $N C^{[7]}$ | $N C^{[7]}$ | $1 / \mathrm{O}_{10 \mathrm{~L}}$ | H |
| J | $\mathrm{A}_{3 \mathrm{~L}}$ | $\mathrm{A}_{7}$ | $\mathrm{A}_{10 \mathrm{~L}}$ | IRR0 ${ }^{[5]}$ | V Cc | $\mathrm{V}_{\text {ss }}$ | $\mathrm{I} / \mathrm{O}_{4 \mathrm{~L}}$ | $1 / \mathrm{O}_{6 \mathrm{~L}}$ | I/ $\mathrm{O}_{8 \mathrm{~L}}$ | $1 / \mathrm{O}_{9}$ | J |
| K | $\mathrm{A}_{6 \mathrm{~L}}$ | $\mathrm{A}_{8 \mathrm{~L}}$ | $\mathrm{A}_{11 \mathrm{~L}}$ | $\overline{U B}_{L}$ | $\overline{\mathrm{SEM}_{\mathrm{L}}}$ | $\mathrm{R} / \bar{W}_{\mathrm{L}}$ | $\mathrm{I} / \mathrm{O}_{0}$ | $1 / \mathrm{O}_{2 \mathrm{~L}}$ | $1 / \mathrm{O}_{5 \mathrm{~L}}$ | $1 / \mathrm{O}_{7}$ | K |
|  | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 |  |

Notes:
3. A12L and A12R are NC pins for CYDM064A16.
4. IRR functionality is not supported for the CYDM256A16 device.
5. This pin is A13L for CYDM256A16 device.
6. This pin is A13R for CYDM256A16 device.
7. Leave this pin unconnected. No trace or power component can be connected to this pin.
8. IRR functionality not supported for the CYDM256A16 device. Connect this pin to $\mathrm{V}_{\mathrm{CC}}$.

Pin Configurations (continued) ${ }^{[7,9,10,11,12,13]}$
100-Ball $0.5-\mathrm{mm}$ Pitch BGA
Top View
CYDM064A08/CYDM128A08

|  | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| A | $\mathrm{A}_{5 \mathrm{R}}$ | $\mathrm{A}_{8 \mathrm{R}}$ | $\mathrm{A}_{11 \mathrm{R}}$ | VCC | $\mathrm{V}_{\mathrm{SS}}$ | $\overline{\mathrm{SEM}}_{\mathrm{R}}$ | $\mathrm{V}_{\text {SS }}$ | $\mathrm{V}_{\text {S }}$ | $\mathrm{V}_{\mathrm{SS}}$ | $\mathrm{V}_{\mathrm{SS}}$ | A |
| B | $\mathrm{A}_{3 \mathrm{R}}$ | $\mathrm{A}_{4 \mathrm{R}}$ | $\mathrm{A}_{7 \mathrm{R}}$ | $\mathrm{A}_{9 R}$ | $\overline{\mathrm{CE}}_{\mathrm{R}}$ | $\mathrm{R} \overline{\mathrm{W}}_{\mathrm{R}}$ | $\overline{\mathrm{OE}}_{\mathrm{R}}$ | $\mathrm{V}_{\mathrm{CC}}$ | $\mathrm{V}_{\mathrm{ss}}$ | $1 / \mathrm{O}_{6 \mathrm{R}}$ | B |
| C | $A_{\text {or }}$ | $\mathrm{A}_{1 \mathrm{R}}$ | $\mathrm{A}_{2 \mathrm{R}}$ | $\mathrm{A}_{6 \mathrm{R}}$ | $\mathrm{V}_{\text {ss }}$ | $\operatorname{IRR1} 1^{[11]}$ | $\mathrm{V}_{\text {SS }}$ | $\mathrm{V}_{\text {Ss }}$ | $\mathrm{I} / \mathrm{O}_{7 \mathrm{R}}$ | $\mathrm{V}_{\text {SS }}$ | C |
| D | ODR4 | ODR2 | $\overline{\operatorname{BUSY}}_{\mathrm{R}}$ | $\overline{\mathrm{INT}}_{\mathrm{R}}$ | $\mathrm{A}_{10 \mathrm{R}}$ | $\mathrm{A}_{12 \mathrm{R}}$ | $\mathrm{V}_{\mathrm{ss}}$ | $V_{s s}$ | $1 / O_{5 R}$ | $1 / \mathrm{O}_{2 \mathrm{R}}$ | D |
| E | $V_{\text {SS }}$ | M/ $\bar{S}$ | ODR3 | $\overline{\mathrm{INT}}_{\mathrm{L}}$ | $\mathrm{V}_{\text {ss }}$ | $V_{S S}$ | $1 / \mathrm{O}_{4 \mathrm{R}}$ | $\mathrm{V}_{\mathrm{cc}}$ | $\mathrm{I} / \mathrm{O}_{1 \mathrm{R}}$ | $\mathrm{V}_{\text {ss }}$ | E |
| F | $\overline{\text { SFEN }}{ }^{[13}$ | ODR1 | $\overline{B U S Y}_{L}$ | $\mathrm{A}_{12}$ | $\mathrm{V}_{\mathrm{CC}}$ | $V_{S S}$ | $1 / \mathrm{O}_{3 \mathrm{R}}$ | $\mathrm{l} / \mathrm{O}_{0 \mathrm{R}}$ | $\mathrm{V}_{\mathrm{SS}}$ | $\mathrm{V}_{\mathrm{Cc}}$ | F |
| G | ODR0 | $\mathrm{A}_{2 L}$ | $\mathrm{A}_{5 L}$ | $\mathrm{A}_{12 \mathrm{~L}}$ | $\overline{\mathrm{OE}}_{\mathrm{L}}$ | $\mathrm{l} / \mathrm{O}_{3 \mathrm{~L}}$ | $\mathrm{V}_{\mathrm{SS}}$ | $\mathrm{V}_{\mathrm{SS}}$ | $\mathrm{V}_{\mathrm{SS}}$ | $\mathrm{V}_{\mathrm{SS}}$ | G |
| H | $A_{0 L}$ | $\mathrm{A}_{4 \mathrm{~L}}$ | AgL | VSS | $\overline{\mathrm{CE}}_{\mathrm{L}}$ | $\mathrm{I} / \mathrm{O}_{1 \mathrm{~L}}$ | $\mathrm{V}_{\mathrm{cc}}$ | $N C^{[12]}$ | $N C^{[12]}$ | $\mathrm{V}_{\text {SS }}$ | H |
| J | $\mathrm{A}_{3 \mathrm{~L}}$ | $\mathrm{A}_{7}$ | $\mathrm{A}_{10 \mathrm{~L}}$ | $\begin{gathered} \text { IRRO } \\ {[10]} \end{gathered}$ | $\mathrm{V}_{\mathrm{cc}}$ | $\mathrm{V}_{\text {SS }}$ | I/O4L | $1 / \mathrm{O}_{6 \mathrm{~L}}$ | $\mathrm{V}_{\text {SS }}$ | $\mathrm{V}_{\text {SS }}$ | J |
| K | $\mathrm{A}_{6 L}$ | $\mathrm{A}_{8 \mathrm{~L}}$ | $\mathrm{A}_{11 \mathrm{~L}}$ | $\mathrm{V}_{\mathrm{cc}}$ | $\overline{S E M}_{\text {L }}$ | $\mathrm{R} \bar{W}_{\mathrm{L}}$ | $1 / \mathrm{O}_{0}$ | $1 / \mathrm{O}_{2 \mathrm{~L}}$ | $1 / O_{5 L}$ | $1 / O_{7}$ | K |
|  | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 |  |

## Notes:

9. IRR functionality is not supported for the CYDM128A08 device.
10. This pin is A13L for CYDM128A08 devices.
11. This pin is A13R for CYDM128A08 devices.
12. Leave this pin unconnected. No trace or power component can be connected to this pin.
13. IRR functionality is not supported for the CYDM128A08. Connect this pin to $V_{D D}$.

## Pin Definitions

| Left Port | Right Port | Description |
| :---: | :---: | :---: |
| $\overline{\mathrm{CE}}_{\mathrm{L}}$ | $\overline{C E}_{R}$ | Chip Enable |
| $\mathrm{R} / \bar{W}_{\mathrm{L}}$ | $\mathrm{R} / \bar{W}_{\mathrm{R}}$ | Read/Write Enable |
| $\overline{\mathrm{OE}}_{\mathrm{L}}$ | $\overline{\mathrm{OE}}_{\mathrm{R}}$ | Output Enable |
| $\mathrm{A}_{0 \mathrm{~L}}-\mathrm{A}_{13 \mathrm{~L}}$ | $\mathrm{A}_{0 \mathrm{R}}-\mathrm{A}_{13 \mathrm{R}}$ | Address ( $A_{0}-A_{11}$ for 4 K devices; $\mathrm{A}_{0}-\mathrm{A}_{12}$ for 8 K devices; $\mathrm{A}_{0}-\mathrm{A}_{13}$ for 16K devices). |
| $\mathrm{l} / \mathrm{O}_{0 \mathrm{~L}}-\mathrm{l} / \mathrm{O}_{15 \mathrm{~L}}$ | $\mathrm{I} / \mathrm{O}_{0 \mathrm{R}^{-1 / O_{15 R}}}$ | Data Bus Input/Output for $\mathbf{x 1 6}$ devices; $\mathrm{I} / \mathrm{O}_{0}-1 / \mathrm{O}_{7}$ for $\times 8$ devices. |
| $\overline{\mathrm{SEM}}_{\mathrm{L}}$ | $\overline{\mathrm{SEM}}_{\mathrm{R}}$ | Semaphore Enable |
| $\overline{\overline{U B}}_{\underline{L}}$ | $\overline{\mathrm{UB}}_{\mathrm{R}}$ | Upper Byte Select ( $1 / \mathrm{O}_{8}-1 / \mathrm{O}_{15}$ for $\mathbf{x 1 6}$ devices; Not applicable for $\mathbf{x 8}$ devices). |
| $\overline{\mathrm{LB}}_{\mathrm{L}}$ | $\overline{\mathrm{LB}}_{\mathrm{R}}$ | Lower Byte Select (I/ $\mathrm{O}_{0}-1 / \mathrm{O}_{7}$ for $\times 16$ devices; Not applicable for x 8 devices). |
| $\overline{\mathrm{INT}}_{\mathrm{L}}$ | $\overline{\mathrm{INT}}_{\mathrm{R}}$ | Interrupt Flag |
| $\overline{\text { BUSY }}_{\text {L }}$ | $\overline{B U S Y}_{R}$ | Busy Flag |
| IRR0, IRR1 |  | Input Read Register for CYDM064A16, CYDM064A08, CYDM128A16. A13L, A13R for CYDM256A16 and CYDM128A08 devices. |
| ODR0-ODR4 |  | Output Drive Register; These outputs are Open Drain. |
| $\overline{\text { SFEN }}$ |  | Special Function Enable |
| M/S |  | Master or Slave Select |
| $\mathrm{V}_{\mathrm{CC}}$ |  | Power |
| GND |  | Ground |
| NC |  | No Connect. Leave this pin Unconnected. |

## Functional Description

The CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 are low-power CMOS 4K, $8 \mathrm{~K}, 16 \mathrm{~K} \times 16$, and $8 / 16 \mathrm{~K} \times 8$ dual-port static RAMs. Arbitration schemes are included on the devices to handle situations when multiple processors access the same piece of data. Two ports are provided, permitting independent, asynchronous access for reads and writes to any location in memory. The devices can be utilized as standalone 16-bit dual-port static RAMs or multiple devices can be combined in order to function as a 32-bit or wider master/slave dual-port static RAM. An M/ $\overline{\mathrm{S}}$ pin is provided for implementing 32-bit or wider memory applications without the need for separate master and slave devices or additional discrete logic. Application areas include interprocessor/multiprocessor designs, communications status buffering, and dual-port video/graphics memory.
Each port has independent control pins: Chip Enable ( $\overline{\mathrm{CE}}$ ), Read or Write Enable ( $\mathrm{R} / \overline{\mathrm{W}}$ ), and Output Enable ( $\overline{\mathrm{OE}) \text {. Two }}$ flags are provided on each port (BUSY and INT). BUSY signals that the port is trying to access the same location currently being accessed by the other port. The Interrupt flag (INT) permits communication between ports or systems by means of a mail box. The semaphores are used to pass a flag, or token, from one port to the other to indicate that a shared resource is in use. The semaphore logic is comprised of eight shared latches. Only one side can control the latch (semaphore) at any time. Control of a semaphore indicates that a shared resource is in use. An automatic power-down feature is controlled independently on each port by a Chip Enable ( $\overline{\mathrm{CE}})$ pin.

The CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 are available in 100-ball $0.5-\mathrm{mm}$ Pitch Ball Grid Array (BGA) packages.

## Power Supply

The core and I/O voltages will be $1.8 \mathrm{~V} / 2.5 \mathrm{~V}$ LVCMOS $/ 3.0 \mathrm{~V}$ LVTTL depending on the user's supply voltage. The supply voltage controls both the Core and I/O voltages.

## Write Operation

Data must be set up for a duration of $t_{\text {SD }}$ before the rising edge of $\mathrm{R} / \overline{\mathrm{W}}$ in order to guarantee a valid write. A write operation is controlled by either the R/W pin (see Write Cycle No. 1 waveform) or the $\overline{\mathrm{CE}}$ pin (see Write Cycle No. 2 waveform). Required inputs for non-contention operations are summarized in Table 1.
If a location is being written to by one port and the opposite port attempts to read that location, a port-to-port flowthrough delay must occur before the data is read on the output; otherwise the data read is not deterministic. Data will be valid on the port $t_{D D D}$ after the data is presented on the other port.

## Read Operation

When reading the device, the user must assert both the $\overline{\mathrm{OE}}$ and $\overline{C E}$ pins. Data will be available $t_{A C E}$ after $\overline{C E}$ or $t_{D O E}$ after $\overline{\mathrm{OE}}$ is asserted. If the user wishes to access a semaphore flag, then the SEM pin must be asserted instead of the CE pin, and $\overline{\mathrm{OE}}$ must also be asserted.

## Interrupts

The upper two memory locations may be used for message passing. The highest memory location (FFF for the CYDM064A16, 1FFF for the CYDM128A16 and CYDM064A08,

# CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 

3FFF for the CYDM256A16 and CYDM128A08) is the mailbox for the right port and the second-highest memory location (FFE for the CYDM064A16, 1FFE for the CYDM128A16 and CYDM064A08, 3FFE for the CYDM256A16 and CYDM128A08) is the mailbox for the left port. When one port writes to the other port's mailbox, an interrupt is generated to the owner. The interrupt is reset when the owner reads the contents of the mailbox. The message is user-defined.
Each port can read the other port's mailbox without resetting the interrupt. The active state of the busy signal (to a port) prevents the port from setting the interrupt to the winning port. Also, an active busy to a port prevents that port from reading its own mailbox and, thus, resetting the interrupt to it.
If an application does not require message passing, do not connect the interrupt pin to the processor's interrupt request input pin. On power up, an initialization program should be run and the interrupts for both ports must be read to reset them.
The operation of the interrupts and their interaction with Busy are summarized in Table 2.

## Busy

The CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 provide on-chip arbitration to resolve simultaneous memory location access (contention). If both ports' $\overline{\text { CEs }}$ are asserted and an address match occurs within $t_{P S}$ of each other, the busy logic will determine which port has access. If $t_{P S}$ is violated, one port will definitely gain permission to the location, but it is not predictable which port will get that permission. $\overline{B U S Y}$ will be asserted $t_{B L A}$ after an address match or $t_{B L C}$ after $\overline{C E}$ is taken LOW.

## Master/Slave

A M/ $\bar{S}$ pin is provided in order to expand the word width by configuring the device as either a master or a slave. The BUSY output of the master is connected to the BUSY input of the slave. This will allow the device to interface to a master device with no external components. Writing to slave devices must be delayed until after the BUSY input has settled ( $\mathrm{t}_{\text {BLC }}$ or $\mathrm{t}_{\text {BLA }}$ ), otherwise, the slave chip may begin a write_cycle during a contention situation. When tied HIGH, the M/S pin allows the device to be used as a master and, therefore, the BUSY line is an output. BUSY can then be used to send the arbitration outcome to a slave.

## Input Read Register

The Input Read Register (IRR) captures the status of two external input devices that are connected to the Input Read pins.
The contents of the IRR read from address $x 0000$ from either port. During reads from the IRR, DQ0 and DQ1 are valid bits and $D Q<15: 2>$ are don't care. Writes to address x0000 are not allowed from either port.
Address $\times 0000$ is not available for standard memory accesses when SFEN $=\mathrm{V}_{\mathrm{IL}}$. When SFEN $=\mathrm{V}_{\mathrm{IH}}$, address x 0000 is available for memory accesses.
The inputs will be $1.8 \mathrm{~V} / 2.5 \mathrm{~V}$ LVCMOS/3.0V LVTTL depending on the user's supply voltage. Refer to Table 3 for Input Read Register operation.

## Output Drive Register

The Output Drive Register (ODR) determines the state of up to five external binary state devices by providing a path to $\mathrm{V}_{\mathrm{SS}}$ for the external circuit. These outputs are Open Drain.
The five external devices can operate at different voltages $\left(1.5 \mathrm{~V} \leq \mathrm{V}_{\text {DDIO }} \leq 3.5 \mathrm{~V}\right.$ ) but the combined current cannot exceed 40 mA ( 8 mA max for each external device). The status of the ODR bits are set using standard write accesses from either port to address x0001 with a " 1 " corresponding to on and " 0 " corresponding to off.
The status of the ODR bits can be read with a standard read access to address $\times 0001$. When $\overline{\text { SFEN }}=\mathrm{V}_{\mathrm{IL}}$, the ODR is active and address x0001 is not available for memory accesses. When $\overline{\text { SFEN }}=\mathrm{V}_{\mathrm{IH}}$, the ODR is inactive and address $\times 0001$ can be used for standard accesses.
During reads and writes to ODR $D Q<4: 0>$ are valid and DQ<15:5> are don't care. Refer to Table 4 for Output Drive Register operation.

## Semaphore Operation

The CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 provide eight semaphore latches, which are separate from the dual-port memory locations. Semaphores are used to reserve resources that are shared between the two ports. The state of the semaphore indicates that a resource is in use. For example, if the left port wants to request a given resource, it sets a latch by writing a zero to a semaphore location. The left port then verifies its success in setting the latch by reading it. After writing to the semaphore, SEM or OE must be deasserted for t $_{\text {SOP }}$ before attempting to read the semaphore. The semaphore value will be available $t_{\text {SWRD }}+t_{\text {DOE }}$ after the rising edge of the semaphore write. If the left port was successful (reads a zero), it assumes control of the shared resource, otherwise (reads a one) it assumes the right port has control and continues to poll the semaphore. When the right side has relinquished control of the semaphore (by writing a one), the left side will succeed in gaining control of the semaphore. If the left side no longer requires the semaphore, a one is written to cancel its request. Semaphores are accessed by asserting $\overline{\text { SEM }}$ LOW. The $\overline{\text { SEM }}$ pin functions as a chip select for the semaphore latches (CE must remain HIGH during SEM LOW). $A_{0-2}$ represents the semaphore address. $\overline{O E}$ and $R / \bar{W}$ are used in the same manner as a normal memory access. When writing or reading a semaphore, the other address pins have no effect.
When writing to the semaphore, only $\mathrm{I} / \mathrm{O}_{0}$ is used. If a zero is written to the left port of an available semaphore, a one will appear at the same semaphore address on the right port. That semaphore can now only be modified by the side showing zero (the left port in this case). If the left port now relinquishes control by writing a one to the semaphore, the semaphore will be set to one for both sides. However, if the right port had requested the semaphore (written a zero) while the left port had control, the right port would immediately own the semaphore as soon as the left port released it. Table 5 shows sample semaphore operations.
When reading a semaphore, all sixteen/eight data lines output the semaphore value. The read value is latched in an output register to prevent the semaphore from changing state during a write from the other port. If both ports attempt to access the semaphore within $\mathrm{t}_{\text {SPS }}$ of each other, the semaphore will definitely be obtained by one side or the other, but there is no

# CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 

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guarantee which side will control the semaphore. On power-up, both ports should write " 1 " to all eight semaphores.

## Architecture

The CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 consist of an array of 4K, 8K, or 16 K words of 16 dual-port RAM cells, I/O and address lines, and control signals ( $\overline{C E}, \overline{O E}, R / \bar{W}$ ). The CYDM064A08 and CYDM128A08 consist of an array of 8 K and 16 K words of 8 each of dual-port RAM cells, I/O and address lines, and control signals ( $\overline{C E}, \overline{O E}, R / \bar{W})$. These control pins permit independent
access for reads or writes to any location in memory. To handle simultaneous writes/reads to the same location, a BUSY pin is provided on each port. Two Interrupt (INT) pins can be utilized for port-to-port communication. Two Semaphore (SEM) control pins are used for allocating shared resources. With the M/S pin, the devices can function as a master (BUSY pins are outputs) or as a slave ( $\overline{\mathrm{BUSY}}$ pins are inputs). The devices also have an automatic power-down feature controlled by $\overline{\mathrm{CE}}$. Each port is provided with its own output enable control ( $\overline{\mathrm{OE}}$ ), which allows data to be read from the device.

Table 1. Non-Contending Read/Write

| Inputs |  |  |  |  |  | Outputs |  | Operation |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\overline{C E}$ | R/W | $\overline{\mathrm{OE}}$ | $\overline{\text { UB }}$ | $\overline{\text { LB }}$ | $\overline{\text { SEM }}$ | $\mathrm{I} / \mathrm{O}_{8}-\mathrm{l} / \mathrm{O}_{15}{ }^{[14]}$ | $\mathrm{I} / \mathrm{O}_{0}-1 / \mathrm{O}_{7}$ |  |
| H | X | X | X | X | H | High Z | High Z | Deselected: Power-down |
| X | X | X | H | H | H | High Z | High Z | Deselected: Power-down |
| L | L | X | L | H | H | Data In | High Z | Write to Upper Byte Only |
| L | L | X | H | L | H | High Z | Data In | Write to Lower Byte Only |
| L | L | X | L | L | H | Data In | Data In | Write to Both Bytes |
| L | H | L | L | H | H | Data Out | High Z | Read Upper Byte Only |
| L | H | L | H | L | H | High Z | Data Out | Read Lower Byte Only |
| L | H | L | L | L | H | Data Out | Data Out | Read Both Bytes |
| X | X | H | X | X | X | High Z | High Z | Outputs Disabled |
| H | H | L | X | X | L | Data Out | Data Out | Read Data in Semaphore Flag |
| X | H | L | H | H | L | Data Out | Data Out | Read Data in Semaphore Flag |
| H | - | X | X | X | L | Data In | Data In | Write $\mathrm{D}_{\text {INO }}$ into Semaphore Flag |
| X | - | X | H | H | L | Data In | Data In | Write $\mathrm{D}_{\text {INO }}$ into Semaphore Flag |
| L | X | X | L | X | L |  |  | Not Allowed |
| L | X | X | X | L | L |  |  | Not Allowed |

Table 2. Interrupt Operation Example (Assumes $\left.\overline{\mathrm{BUSY}}_{\mathrm{L}}=\overline{\mathrm{BUSY}}_{\mathrm{R}}=\mathrm{HIGH}\right)^{[15]}$

| Function | Left Port |  |  |  |  | Right Port |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | $\mathrm{R} / \bar{W}_{\mathrm{L}}$ | $\overline{\mathrm{CE}}_{\mathrm{L}}$ | $\overline{\mathrm{OE}}_{\mathrm{L}}$ | $\mathrm{A}_{0 \mathrm{~L}-13 \mathrm{~L}}$ | $\overline{\mathbf{I N T}}_{\mathrm{L}}$ | $\mathrm{R} / \bar{W}_{\mathrm{R}}$ | $\overline{C E}_{R}$ | $\overline{\mathrm{OE}}_{\mathrm{R}}$ | A0R-13R | $\overline{\mathrm{INT}}_{\mathrm{R}}$ |
| Set Right $\overline{\mathrm{NT}}_{\mathrm{R}}$ Flag | L | L | X | 3FFF ${ }^{[18]}$ | X | X | X | X | X | $L^{[17]}$ |
| Reset Right $\overline{\mathrm{NT}}_{\mathrm{R}}$ Flag | X | X | X | X | X | X | L | L | 3FFF ${ }^{[18]}$ | $\mathrm{H}^{[16]}$ |
| Set Left $\overline{\mathrm{INT}}_{\mathrm{L}}$ Flag | X | X | X | X | $L^{[16]}$ | L | L | X | 3FFE ${ }^{[18]}$ | X |
| Reset Left $\overline{\mathrm{INT}}_{\mathrm{L}}$ Flag | X | L | L | $3 F F E^{[18]}$ | $\mathrm{H}^{[17]}$ | X | X | X | X | X |

Table 3. Input Read Register Operation ${ }^{[19, ~ 22]}$

| SFEN | CE | R/W | OE | UB | LB | ADDR | $1 / \mathrm{O}_{0}-1 / \mathrm{O}_{1}$ | $\mathrm{I} / \mathrm{O}_{2}-1 / \mathrm{O}_{15}$ | Mode |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| H | L | H | L | L | L | x0000-Max | VALID ${ }^{[20]}$ | VALID ${ }^{[20]}$ | Standard Memory Access |
| L | L | H | L | X | L | x0000 | VALID ${ }^{[21]}$ | X | IRR Read |

## Notes:

14. This column applies to $\times 16$ devices only.
15. See Interrupts Functional Description for specific highest memory locations by device.
16. If $B_{B U S Y}^{R}=L$, then no change.
17. If $\overline{B U S Y}_{L}=L$, then no change.
18. See Functional Description for specific addresses by device.
19. SFEN $=$ VIL for IRR reads
20. $\overline{\mathrm{UB}}$ or $\overline{\mathrm{LB}}=\mathrm{V}_{I L}$. If $\overline{\mathrm{LB}}=\mathrm{V}_{I L}$, then $\mathrm{DQ}<7: 0>$ are valid. If $\overline{\mathrm{UB}}=\mathrm{V}_{\mathrm{IL}}$ then $\mathrm{DQ}<15: 8>$ are valid.
21. $\overline{L B}$ must be active $\left(\overline{\mathrm{LB}}=\mathrm{V}_{1 L}\right)$ for these bits to be valid.
22. SFEN active when either $\overline{C E}_{L}=V_{I L}$ or $\overline{C E}_{R}=V_{I L}$. It is inactive when $\overline{C E}_{L}=\overline{C E}_{R}=V_{I H}$.

# CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, 

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Table 4. Output Drive Register ${ }^{[25]}$

| $\overline{\text { SFEN }}$ | $\overline{C E}$ | R/W | $\overline{\mathrm{OE}}$ | $\overline{\text { UB }}$ | LB | ADDR | $\mathrm{I} / \mathrm{O}_{0}-\mathrm{I} / \mathrm{O}_{4}$ | $\mathrm{I} / \mathrm{O}_{5}-\mathrm{l} / \mathrm{O}_{15}$ | Mode |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| H | L | H | $\mathrm{X}^{[26]}$ | $L^{[23]}$ | $L^{[23]}$ | x0000-Max | VALID ${ }^{[23]}$ | VALID ${ }^{[23]}$ | Standard Memory Access |
| L | L | L | X | X | L | x0001 | VALID ${ }^{[24]}$ | X | ODR Write ${ }^{[25,27]}$ |
| L | L | H | L | X | L | x0001 | VALID ${ }^{[24]}$ | X | ODR Read ${ }^{[25]}$ |

Table 5. Semaphore Operation Example

| Function | $\mathrm{I} / \mathrm{O}_{0}-1 / \mathrm{O}_{15}$ Left | I/O $\mathbf{O}^{-1 / O_{15} \text { Right }}$ | Status |
| :---: | :---: | :---: | :---: |
| No action | 1 | 1 | Semaphore-free |
| Left port writes 0 to semaphore | 0 | 1 | Left Port has semaphore token |
| Right port writes 0 to semaphore | 0 | 1 | No change. Right side has no write access to semaphore |
| Left port writes 1 to semaphore | 1 | 0 | Right port obtains semaphore token |
| Left port writes 0 to semaphore | 1 | 0 | No change. Left port has no write access to semaphore |
| Right port writes 1 to semaphore | 0 | 1 | Left port obtains semaphore token |
| Left port writes 1 to semaphore | 1 | 1 | Semaphore-free |
| Right port writes 0 to semaphore | 1 | 0 | Right port has semaphore token |
| Right port writes 1 to semaphore | 1 | 1 | Semaphore free |
| Left port writes 0 to semaphore | 0 | 1 | Left port has semaphore token |
| Left port writes 1 to semaphore | 1 | 1 | Semaphore-free |

## Notes:

23. $\overline{\mathrm{UB}}$ or $\overline{\mathrm{LB}}=\mathrm{V}_{\mathrm{IL}}$. If $\overline{\mathrm{LB}}=\mathrm{V}_{\mathrm{IL}}$, then $\mathrm{DQ}<7: 0>$ are valid. If $\overline{\mathrm{UB}}=\mathrm{V}_{\mathrm{IL}}$ then $\mathrm{DQ}<15: 8>$ are valid.
24. $\overline{\mathrm{LB}}$ must be active $\left(\overline{\mathrm{LB}}=\mathrm{V}_{\text {IL }}\right)$ for these bits to be valid.
25. $\mathrm{SFEN}=\mathrm{V}_{\mathrm{IL}}$ for ODR reads and writes.
26. Output enable must be low ( $\mathrm{OE}=\mathrm{V}_{\mathrm{IL}}$ ) during reads for valid data to be output.
27. During ODR writes data will also be written to the memory

# CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, <br> CYDM064A08 

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## Maximum Ratings ${ }^{[28]}$

(Above which the useful life may be impaired. For user guidelines, not tested.)
Storage Temperature $\qquad$ $-65^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$
Ambient Temperature with
Power Applied $\qquad$ $-55^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$
Supply Voltage to Ground Potential ............... -0.5 V to +3.3 V
DC Voltage Applied to
Outputs in High-Z State.......................... -0.5 V to $\mathrm{V}_{\mathrm{CC}}+0.5 \mathrm{~V}$


Output Current into Outputs (LOW)............................. 90 mA
Static Discharge Voltage.......................................... > 2000V
Latch-up Current.................................................... > 200 mA
Operating Range

| Range | Ambient Temperature | $\mathbf{V}_{\mathbf{C C}}$ |
| :--- | :---: | :---: |
| Commercial | $0^{\circ} \mathrm{C}$ to $+70^{\circ} \mathrm{C}$ | $1.8 \mathrm{~V} \pm 100 \mathrm{mV}$ |
|  |  | $2.5 \mathrm{~V} \pm 100 \mathrm{mV}$ |
|  |  | $3.0 \mathrm{~V} \pm 300 \mathrm{mV}$ |
| Industrial | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | $1.8 \mathrm{~V} \pm 100 \mathrm{mV}$ |
|  |  | $2.5 \mathrm{~V} \pm 100 \mathrm{mV}$ |
|  |  | $3.0 \mathrm{~V} \pm 300 \mathrm{mV}$ |

Electrical Characteristics for 1.8 V Over the Operating Range

| Parameter | Description |  | CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  |  | CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | -35 |  |  | -55 |  |  |  |
|  |  |  | Min. | Typ. | Max. | Min. | Typ. | Max. |  |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage ( $\mathrm{l}_{\mathrm{OH}}=-100 \mu \mathrm{~A}$ ) |  | $\mathrm{V}_{\mathrm{CC}}-0.2$ |  |  | $\mathrm{V}_{\mathrm{CC}}-0.2$ |  |  | V |
| $\mathrm{V}_{\mathrm{OL}}$ | Output LOW Voltage ( $\mathrm{I}_{\mathrm{OL}}=100 \mu \mathrm{~A}$ ) |  |  |  | 0.2 |  |  | 0.2 | V |
| $\mathrm{V}_{\text {OL }}$ ODR | ODR Output LOW Voltage ( $\mathrm{I}_{\mathrm{OL}}=2 \mathrm{~mA}$ ) |  |  |  | 0.2 |  |  | 0.2 | V |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage |  | 1.2 |  | $\mathrm{V}_{\mathrm{CC}}+0.2$ | 1.2 |  | $\mathrm{V}_{\mathrm{CC}}+0.2$ | V |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage |  | -0.2 |  | 0.4 | -0.2 |  | 0.4 | V |
| IOz | Output Leakage Current |  | -1 |  | 1 | -1 |  | 1 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {CEX }}$ ODR | ODR Output Leakage Current. $\mathrm{V}_{\text {OUT }}=\mathrm{V}_{\text {CC }}$ |  | -1 |  | 1 | -1 |  | 1 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\mathrm{IX}}$ | Input Leakage Current |  | -1 |  | 1 | -1 |  | 1 | $\mu \mathrm{A}$ |
| ICC | Operating Current ( $\mathrm{V}_{\mathrm{CC}}=$ Max., $\left.\mathrm{I}_{\mathrm{OUT}}=0 \mathrm{~mA}\right)$ Outputs Disabled | Ind. |  | 25 | 40 |  | 15 | 25 | mA |
| $\mathrm{I}_{\text {SB1 }}$ | Standby Current (Both Ports TTL Level) $\overline{\mathrm{CE}}_{\mathrm{L}}$ and $\mathrm{CE}_{\mathrm{R}} \geq \mathrm{V}_{\mathrm{CC}}-0.2, \mathrm{SEM}_{\mathrm{L}}=\mathrm{SEM}_{\mathrm{R}}=\mathrm{SFEN}$ $=V_{C C}-0.2, f=f_{\text {MAX }}$ | Ind. |  | 2 | 6 |  | 2 | 6 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {SB2 }}$ | Standby Current (One Port TTL Level) $\overline{\mathrm{CE}}_{\mathrm{L}}$ I $\mathrm{CE}_{\mathrm{R}} \geq \mathrm{V}_{\mathrm{IH}}, \mathrm{f}=\mathrm{f}_{\mathrm{MAX}}$ | Ind. |  | 8.5 | 18 |  | 8.5 | 14 | mA |
| $\mathrm{I}_{\text {SB3 }}$ | Standby Current (Both Ports CMOS Level) $\overline{\mathrm{CE}}_{\mathrm{L}}$ \& $\mathrm{CE}_{\mathrm{R}} \geq \mathrm{V}_{\mathrm{CC}}-0.2 \mathrm{~V}, \mathrm{SEM}_{\mathrm{L}}$, SEM $_{\mathrm{R}}$, and SFEN $>V_{C C}-0.2 V, f=0$ | Ind. |  | 2 | 6 |  | 2 | 6 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {SB4 }}$ | Standby Current (One Port CMOS Level) $\overline{\mathrm{CE}}_{\mathrm{L}}$ $\mid \overline{C E}_{R} \geq V_{I H}, f=f_{M A X}{ }^{[30]}$ | Ind. |  | 8.5 | 18 |  | 8.5 | 14 | mA |

## Notes:

28. The voltage on any input or I/O pin can not exceed the power pin during power-up.
29. Pulse width $<20 \mathrm{~ns}$.
30. $f_{\text {MAX }}=1 / \mathrm{t}_{\text {RC }}=$ All inputs cycling at $\mathrm{f}=1 / \mathrm{t}_{\mathrm{RC}}$ (except output enable). $\mathrm{f}=0$ means no address or control lines change. This applies only to inputs at CMOS level standby lob

# CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 

Electrical Characteristics for 2.5V Over the Operating Range

| Parameter | Description |  | CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  |  | CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | -35 |  |  | -55 |  |  |  |
|  |  |  | Min. | Typ. | Max. | Min. | Typ. | Max. |  |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage ( $\mathrm{IOH}^{\text {a }}=-2 \mathrm{~mA}$ ) |  | 2.0 |  |  | 2.0 |  |  | V |
| $\mathrm{V}_{\mathrm{OL}}$ | Output LOW Voltage ( $\mathrm{I}_{\mathrm{OL}}=2 \mathrm{~mA}$ ) |  |  |  | 0.4 |  |  | 0.4 | V |
| $\mathrm{V}_{\text {OL }}$ ODR | ODR Output LOW Voltage ( $\mathrm{I}_{\mathrm{OL}}=5 \mathrm{~mA}$ ) |  |  |  | 0.4 |  |  | 0.4 | V |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage |  | 1.7 |  | $\mathrm{V}_{\mathrm{CC}}+0.3$ | 1.7 |  | $\mathrm{V}_{\mathrm{CC}}+0.3$ | V |
| $\mathrm{V}_{\text {IL }}$ | Input LOW Voltage |  | -0.3 |  | 0.6 | -0.3 |  | 0.6 | V |
| $\mathrm{l}_{\mathrm{Oz}}$ | Output Leakage Current |  | -1 |  | 1 | -1 |  | 1 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {CEX }}$ ODR | ODR Output Leakage Current. $\mathrm{V}_{\text {OUT }}=\mathrm{V}_{\text {CC }}$ |  | -1 |  | 1 | -1 |  | 1 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\mathrm{IX}}$ | Input Leakage Current |  | -1 |  | 1 | -1 |  | 1 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {CC }}$ | Operating Current ( $\mathrm{V}_{\mathrm{CC}}=$ Max., IOUT $=0 \mathrm{~mA}$ ) Outputs Disabled | Ind. |  | 39 | 55 |  | 28 | 40 | mA |
| $\mathrm{I}_{\text {SB1 }}$ | Standby Current (Both Ports TTL Level) $\mathrm{CE}_{\mathrm{L}}$ and $\overline{\mathrm{CE}}_{\mathrm{R}} \geq \mathrm{V}_{\mathrm{CC}}-0.2$, SEM $_{L}=$ SEM $_{R}=$ SFEN $=$ $\mathrm{V}_{\mathrm{CC}}-0.2, \mathrm{f}=\mathrm{f}_{\text {MAX }}$ | Ind. |  | 6 | 8 |  | 6 | 8 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {SB2 }}$ | Standby Current (One Port TTL Level) $\mathrm{CE}_{\mathrm{L}} \mid \overline{C E}_{\mathrm{R}} \geq \mathrm{V}_{\mathrm{IH}}, \mathrm{f}=\mathrm{f}_{\mathrm{MAX}}$ | Ind. |  | 21 | 30 |  | 18 | 25 | mA |
| ${ }^{\text {SB3 }}$ | Standby Current (Both Ports CMOS Level) $\overline{\mathrm{CE}}_{\mathrm{L}} \& \overline{\mathrm{CE}}_{\mathrm{R}} \geq$ $\mathrm{V}_{\mathrm{CC}}-0.2 \mathrm{~V}$, SEM $_{\mathrm{L}}$, SEM $_{\mathrm{R}}$, and SFEN> $\mathrm{V}_{\mathrm{CC}}-0.2 \mathrm{~V}, \mathrm{f}=0$ | Ind. |  | 4 | 6 |  | 4 | 6 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {SB4 }}$ | Standby Current (One Port CMOS Level) $\overline{C E}_{L} \mid \overline{C E}_{R} \geq V_{I H}, f=f_{M A X}{ }^{[30]}$ | Ind. |  | 21 | 30 |  | 18 | 25 | mA |

Electrical Characteristics for 3.0V Over the Operating Range

| Parameter | Description | CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  |  | CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | -35 |  |  | -55 |  |  |  |
|  |  | Min. | Typ. | Max. | Min. | Typ. | Max. |  |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage ( $\mathrm{l}_{\mathrm{OH}}=-2 \mathrm{~mA}$ ) | 2.1 |  |  | 2.1 |  |  | V |
| $\mathrm{V}_{\mathrm{OL}}$ | Output LOW Voltage ( $\mathrm{I}_{\mathrm{OL}}=2 \mathrm{~mA}$ ) |  |  | 0.4 |  |  | 0.4 | V |
| $\mathrm{V}_{\text {OL }}$ ODR | ODR Output LOW Voltage ( $\mathrm{I}_{\mathrm{OL}}=8 \mathrm{~mA}$ ) |  |  | 0.5 |  |  | 0.5 | V |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage | 2.0 |  | $\mathrm{V}_{\mathrm{CC}}+0.2$ | 2.0 |  | $\mathrm{V}_{\mathrm{CC}}+0.2$ | V |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage | -0.2 |  | 0.7 | -0.2 |  | 0.7 | V |
| IOz | Output Leakage Current | -1 |  | 1 | -1 |  | 1 | $\mu \mathrm{A}$ |
| ICEXODR | ODR Output Leakage Current. $\mathrm{V}_{\text {OUT }}=\mathrm{V}_{\text {CC }}$ | -1 |  | 1 | -1 |  | 1 | $\mu \mathrm{A}$ |
| IIX | Input Leakage Current | -1 |  | 1 | -1 |  | 1 | $\mu \mathrm{A}$ |

# CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, <br> CYDM064A08 

Electrical Characteristics for 3.0V Over the Operating Range (continued)

| Parameter | Description |  | CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  |  | CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | -35 |  |  | -55 |  |  |  |
|  |  |  | Min. | Typ. | Max. | Min. | Typ. | Max. |  |
| ICC | Operating Current ( $\mathrm{V}_{\mathrm{CC}}=$ Max., IOUT $=0 \mathrm{~mA}$ ) Outputs Disabled | Ind. |  | 49 | 70 |  | 42 | 60 | mA |
| ${ }^{\text {SB1 }}$ | Standby Current (Both Ports TTL <br> Level) $\overline{C E}_{L}$ and $\overline{C E}_{R} \geq V_{C C}-0.2$, <br> $\mathrm{SEM}_{\mathrm{L}}=\mathrm{SEM}_{\mathrm{R}}=\mathrm{SFEN}=$ <br> $V_{C C}-0.2, f=f_{\text {MAX }}$ | Ind. |  | 7 | 10 |  | 7 | 10 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {SB2 }}$ | Standby Current (One Port TTL Level) $\overline{C E}_{L} \mid \overline{C E}_{R} \geq V_{I H}, f=f_{\text {MAX }}$ | Ind. |  | 28 | 40 |  | 25 | 35 | mA |
| $\mathrm{I}_{\text {SB3 }}$ | Standby Current (Both Ports CMOS Level) $\overline{\mathrm{CE}}_{\mathrm{L}} \& \overline{\mathrm{CE}}_{\mathrm{R}} \geq$ $\mathrm{V}_{\mathrm{CC}}-0.2 \mathrm{~V}, \mathrm{SEM}_{\mathrm{L}}$, SEM $_{\mathrm{R}}$, and SFEN $>\mathrm{V}_{\mathrm{CC}}-0.2 \mathrm{~V}, \mathrm{f}=0$ | Ind. |  | 6 | 8 |  | 6 | 8 | $\mu \mathrm{A}$ |
| $I_{\text {SB4 }}$ | Standby Current (One Port CMOS Level) $\overline{C E}_{L} \mid \overline{C E}_{R} \geq \mathrm{V}_{I H}, \mathrm{f}=\mathrm{f}_{\text {MAX }}{ }^{[30]}$ | Ind. |  | 28 | 40 |  | 25 | 35 | mA |

Capacitance ${ }^{[31]}$

| Parameter | Description | Test Conditions | Max. | Unit |
| :--- | :--- | :--- | :---: | :---: |
| $\mathrm{C}_{\mathbb{I N}}$ | Input Capacitance | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{f}=1 \mathrm{MHz}$, | 9 | pF |
| $\mathrm{C}_{\text {OUT }}$ | Output Capacitance | $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}$ | 10 | pF |

## AC Test Loads and Waveforms


(a) Normal Load (Load 1)

|  | $3.0 \mathrm{~V} / 2.5 \mathrm{~V}$ | 1.8 V |
| :---: | :---: | :---: |
| R1 | $1022 \Omega$ | $13500 \Omega$ |
| R2 | $792 \Omega$ | $10800 \Omega$ |


(b) Thévenin Equivalent (Load 1)

ALL INPUT PULSES


Note:
31. Tested initially and after any design or process changes that may affect these parameters.

# CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 

## Switching Characteristics for 1.8 V Over the Operating Range ${ }^{[32]}$

| Parameter | Description | CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  | CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | -35 |  | -55 |  |  |
|  |  | Min. | Max. | Min. | Max. |  |
| Read Cycle |  |  |  |  |  |  |
| $\mathrm{t}_{\text {RC }}$ | Read Cycle Time | 35 |  | 55 |  | ns |
| $\mathrm{t}_{\mathrm{AA}}$ | Address to Data Valid |  | 35 |  | 55 | ns |
| $\mathrm{t}_{\mathrm{OHA}}$ | Output Hold From Address Change | 5 |  | 5 |  | ns |
| $\mathrm{t}_{\text {ACE }}{ }^{[33]}$ | $\overline{\mathrm{CE}}$ LOW to Data Valid |  | 35 |  | 55 | ns |
| $t_{\text {doe }}$ | $\overline{\mathrm{OE}}$ LOW to Data Valid |  | 20 |  | 30 | ns |
| $\mathrm{t}_{\text {LZOE }}{ }^{[34,35,36]}$ | $\overline{\mathrm{OE}}$ Low to Low Z | 5 |  | 5 |  | ns |
| $\mathrm{t}_{\text {HZOE }}{ }^{[34,35,36]}$ | $\overline{\mathrm{OE}}$ HIGH to High Z |  | 15 |  | 25 | ns |
| $\mathrm{t}_{\text {LZCE }}{ }^{[34,35,36]}$ | $\overline{C E}$ LOW to Low Z | 5 |  | 5 |  | ns |
| $\mathrm{t}_{\text {HZCE }}{ }^{[34,35,36]}$ | $\overline{\text { CE HIGH to High Z }}$ |  | 15 |  | 25 | ns |
| $\mathrm{t}_{\mathrm{Pu}}{ }^{[36]}$ | $\overline{\mathrm{CE}}$ LOW to Power-Up | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {PD }}{ }^{[36]}$ | $\overline{\text { CE }}$ HIGH to Power-Down |  | 35 |  | 55 | ns |
| $\mathrm{t}_{\mathrm{ABE}}{ }^{\text {[33] }}$ | Byte Enable Access Time |  | 35 |  | 55 | ns |
| Write Cycle |  |  |  |  |  |  |
| $\mathrm{t}_{\mathrm{wc}}$ | Write Cycle Time | 35 |  | 55 |  | ns |
| $\mathrm{t}_{\text {SCE }}{ }^{\text {[33] }}$ | $\overline{\mathrm{CE}}$ LOW to Write End | 25 |  | 45 |  | ns |
| $\mathrm{t}_{\text {AW }}$ | Address Valid to Write End | 25 |  | 45 |  | ns |
| $\mathrm{t}_{\mathrm{HA}}$ | Address Hold From Write End | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {SA }}{ }^{[33]}$ | Address Set-up to Write Start | 0 |  | 0 |  | ns |
| trwe | Write Pulse Width | 25 |  | 40 |  | ns |
| $\mathrm{t}_{\text {SD }}$ | Data Set-up to Write End | 20 |  | 30 |  | ns |
| $\mathrm{t}_{\mathrm{HD}}$ | Data Hold From Write End | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {HZWE }}{ }^{[35,36]}$ | R/WW LOW to High Z |  | 15 |  | 25 | ns |
| $\mathrm{t}_{\text {LZWE }}{ }^{[35,36]}$ | R/W/ HIGH to Low Z | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {WDD }}{ }^{[37]}$ | Write Pulse to Data Delay |  | 50 |  | 80 | ns |
| $\mathrm{t}_{\text {DDD }}{ }^{[37]}$ | Write Data Valid to Read Data Valid |  | 40 |  | 65 | ns |
| Busy Timing ${ }^{[38]}$ |  |  |  |  |  |  |
| $t_{\text {BLA }}$ | $\overline{\text { BUSY }}$ LOW from Address Match |  | 25 |  | 45 | ns |
| $\mathrm{t}_{\text {BHA }}$ | $\overline{\text { BUSY HIGH from Address Mismatch }}$ |  | 25 |  | 45 | ns |
| $\mathrm{t}_{\mathrm{BLC}}$ | $\overline{\text { BUSY LOW from } \overline{C E} \text { LOW }}$ |  | 25 |  | 45 | ns |
| $\mathrm{t}_{\mathrm{BHC}}$ | $\overline{\text { BUSY }}$ HIGH from $\overline{\text { CE }}$ HIGH |  | 25 |  | 45 | ns |

Notes:
32. Test conditions assume signal transition time of 3 ns or less, timing reference levels of $V_{D D} / 2$, input pulse levels of 0 to $V_{D D}$, and output loading of the specified $\mathrm{IOI}_{\mathrm{Ol}} \mathrm{I}_{\mathrm{OH}}$ and $30-\mathrm{pF}$ load capacitance.
33. To access RAM, $\overline{C E}=L, \overline{U B}=L, \overline{S E M}=H$. To access semaphore, $\overline{C E}=H$ and $\overline{S E M}=L$. Either condition must be valid for the entire $t_{S C E}$ time
34. At any given temperature and voltage condition for any given device, $t_{\text {HZCE }}$ is less than $t_{\text {LZCE }}$ and $t_{\text {HZOE }}$ is less than $t_{\text {LZOE }}$.
35. Test conditions used are Load 3.
36. This parameter is guaranteed but not tested. For information on port-to-port delay through RAM cells from writing port to reading port, refer to Read Timing with Busy waveform.
37. For information on port-to-port delay through RAM cells from writing port to reading port, refer to Read Timing with Busy waveform
38. Test conditions used are Load 2.

Switching Characteristics for 1.8 V Over the Operating Range ${ }^{[32]}$ (continued)

| Parameter | Description | CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  | CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | -35 |  | -55 |  |  |
|  |  | Min. | Max. | Min. | Max. |  |
| $\mathrm{t}_{\text {PS }}$ | Port Set-up for Priority | 5 |  | 5 |  | ns |
| $\mathrm{t}_{\text {WB }}$ | R/产 HIGH after BUSY (Slave) | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {WH }}$ | R/̄W HIGH after $\overline{\text { BUSY }}$ HIGH (Slave) | 20 |  | 35 |  | ns |
| $\mathrm{t}_{\text {BDD }}{ }^{[39]}$ | $\overline{\text { BUSY }}$ HIGH to Data Valid |  | 25 |  | 40 | ns |
| Interrupt Timing ${ }^{\text {[38] }}$ |  |  |  |  |  |  |
| $\mathrm{t}_{\text {INS }}$ | $\overline{\text { INT Set Time }}$ |  | 31 |  | 45 | ns |
| $\mathrm{t}_{\text {INR }}$ | INT Reset Time |  | 31 |  | 45 | ns |
| Semaphore Timing |  |  |  |  |  |  |
| $\mathrm{t}_{\text {SOP }}$ | SEM Flag Update Pulse ( $\overline{\mathrm{OE}}$ or $\overline{\mathrm{SEM}})$ | 10 |  | 15 |  | ns |
| $\mathrm{t}_{\text {SWRD }}$ | SEM Flag Write to Read Time | 10 |  | 10 |  | ns |
| $\mathrm{t}_{\text {SPS }}$ | SEM Flag Contention Window | 10 |  | 10 |  | ns |
| $\mathrm{t}_{\text {SAA }}$ | SEM Address Access Time |  | 35 |  | 55 | ns |

Switching Characteristics for $\mathbf{2 . 5 V}$ Over the Operating Range


Notes:
39. $t_{B D D}$ is a calculated parameter and is the greater of $t_{W D D} t_{\text {PWE }}$ (actual) or $t_{D D D}-t_{S D}$ (actual).

Switching Characteristics for 2.5V Over the Operating Range (continued)

| Parameter | Description | CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  | CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | -35 |  | -55 |  |  |
|  |  | Min. | Max. | Min. | Max. |  |
| $\mathrm{t}_{\text {AW }}$ | Address Valid to Write End | 25 |  | 45 |  | ns |
| $\mathrm{t}_{\mathrm{HA}}$ | Address Hold From Write End | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {SA }}{ }^{[33]}$ | Address Set-up to Write Start | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {PWE }}$ | Write Pulse Width | 25 |  | 40 |  | ns |
| $\mathrm{t}_{\text {SD }}$ | Data Set-up to Write End | 20 |  | 30 |  | ns |
| $\mathrm{t}_{\mathrm{HD}}$ | Data Hold From Write End | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {HZWE }}{ }^{[35,36]}$ | R/产 LOW to High Z |  | 15 |  | 25 | ns |
| $\mathrm{t}_{\text {LZWE }}{ }^{[35,36]}$ | R/V̄ HIGH to Low Z | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {WDD }}{ }^{[37]}$ | Write Pulse to Data Delay |  | 50 |  | 80 | ns |
| $\mathrm{t}_{\text {DDD }}{ }^{[37]}$ | Write Data Valid to Read Data Valid |  | 40 |  | 65 | ns |
| Busy Timing ${ }^{[38]}$ |  |  |  |  |  |  |
| tbLA | $\overline{\text { BUSY }}$ LOW from Address Match |  | 25 |  | 45 | ns |
| $\mathrm{t}_{\text {BHA }}$ | $\overline{\text { BUSY }}$ HIGH from Address Mismatch |  | 25 |  | 45 | ns |
| $\mathrm{t}_{\mathrm{BLC}}$ | $\overline{\text { BUSY LOW from } \overline{\text { CE }} \text { LOW }}$ |  | 25 |  | 45 | ns |
| $\mathrm{t}_{\mathrm{BHC}}$ | $\overline{\text { BUSY }}$ HIGH from $\overline{\text { CE }}$ HIGH |  | 25 |  | 45 | ns |
| $\mathrm{t}_{\text {PS }}$ | Port Set-up for Priority | 5 |  | 5 |  | ns |
| $\mathrm{t}_{\text {WB }}$ | R/产 HIGH after BUSY (Slave) | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {WH }}$ | R/W HIGH after BUSY HIGH (Slave) | 20 |  | 35 |  | ns |
| $\mathrm{t}_{\text {BDD }}{ }^{\text {[39] }}$ | $\overline{\text { BUSY }}$ HIGH to Data Valid |  | 25 |  | 40 | ns |
| Interrupt Timing ${ }^{[38]}$ |  |  |  |  |  |  |
| tins | $\overline{\text { INT Set Time }}$ |  | 31 |  | 45 | ns |
| $\mathrm{t}_{\text {INR }}$ | INT Reset Time |  | 31 |  | 45 | ns |
| Semaphore Timing |  |  |  |  |  |  |
| $\mathrm{t}_{\text {SOP }}$ | SEM Flag Update Pulse ( $\overline{\mathrm{OE}}$ or $\overline{\mathrm{SEM}})$ | 10 |  | 15 |  | ns |
| $\mathrm{t}_{\text {SWRD }}$ | SEM Flag Write to Read Time | 10 |  | 10 |  | ns |
| $\mathrm{t}_{\text {SPS }}$ | SEM Flag Contention Window | 10 |  | 10 |  | ns |
| $\mathrm{t}_{\text {SAA }}$ | SEM Address Access Time |  | 35 |  | 55 | ns |

Switching Characteristics for 3.0V Over the Operating Range

| Parameter | Description | CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  | CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | -35 |  | -55 |  |  |
|  |  | Min. | Max. | Min. | Max. |  |
| Read Cycle |  |  |  |  |  |  |
| $\mathrm{t}_{\text {RC }}$ | Read Cycle Time | 35 |  | 55 |  | ns |
| $\mathrm{t}_{\mathrm{AA}}$ | Address to Data Valid |  | 35 |  | 55 | ns |
| $\mathrm{t}_{\mathrm{OHA}}$ | Output Hold From Address Change | 5 |  | 5 |  | ns |
| $\mathrm{t}_{\text {ACE }}{ }^{\text {[33] }}$ | $\overline{\mathrm{CE}}$ LOW to Data Valid |  | 35 |  | 55 | ns |
| $\mathrm{t}_{\text {DOE }}$ | $\overline{\mathrm{OE}}$ LOW to Data Valid |  | 20 |  | 30 | ns |
| $\mathrm{t}_{\text {LZOE }}{ }^{[34,35,36]}$ | $\overline{\mathrm{OE}}$ Low to Low Z | 1 |  | 1 |  | ns |
| $\mathrm{t}_{\mathrm{HZO}}{ }^{[34,35,36]}$ | $\overline{\text { OE HIGH to High Z }}$ |  | 15 |  | 25 | ns |
| $\mathrm{t}_{\text {LZCE }}{ }^{[34,35,36]}$ | $\overline{\mathrm{CE}}$ LOW to Low $Z$ | 1 |  | 1 |  | ns |
| $\mathrm{t}_{\mathrm{HZCE}}{ }^{[34,35,36]}$ | $\overline{\text { CE }}$ HIGH to High Z |  | 15 |  | 25 | ns |
| $\mathrm{t}_{\mathrm{PU}}{ }^{[36]}$ | $\overline{\text { CE }}$ LOW to Power-Up | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {PD }}{ }^{[36]}$ | $\overline{\mathrm{CE}}$ HIGH to Power-Down |  | 35 |  | 55 | ns |
| $\mathrm{t}_{\text {ABE }}{ }^{\text {[33] }}$ | Byte Enable Access Time |  | 35 |  | 55 | ns |
| Write Cycle |  |  |  |  |  |  |
| $\mathrm{t}_{\text {wc }}$ | Write Cycle Time | 35 |  | 55 |  | ns |
| $\mathrm{t}_{\text {SCE }}{ }^{\text {[33] }}$ | $\overline{\mathrm{CE}}$ LOW to Write End | 25 |  | 45 |  | ns |
| $\mathrm{t}_{\text {AW }}$ | Address Valid to Write End | 25 |  | 45 |  | ns |
| $\mathrm{t}_{\mathrm{HA}}$ | Address Hold From Write End | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {SA }}{ }^{[33]}$ | Address Set-up to Write Start | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {PWE }}$ | Write Pulse Width | 25 |  | 40 |  | ns |
| $\mathrm{t}_{\text {SD }}$ | Data Set-up to Write End | 20 |  | 30 |  | ns |
| $\mathrm{t}_{\mathrm{HD}}$ | Data Hold From Write End | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {HZWE }}{ }^{[35,36]}$ | R/W LOW to High Z |  | 15 |  | 25 | ns |
| $\mathrm{t}_{\text {LZWE }}{ }^{[35,36]}$ | R/W HIGH to Low Z | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {WDD }}{ }^{[37]}$ | Write Pulse to Data Delay |  | 50 |  | 80 | ns |
| $\mathrm{t}_{\text {DDD }}{ }^{[37]}$ | Write Data Valid to Read Data Valid |  | 40 |  | 65 | ns |
| Busy Timing ${ }^{\text {[38] }}$ |  |  |  |  |  |  |
| $\mathrm{t}_{\text {BLA }}$ | $\overline{\text { BUSY }}$ LOW from Address Match |  | 25 |  | 45 | ns |
| $\mathrm{t}_{\text {BHA }}$ | $\overline{\text { BUSY }}$ HIGH from Address Mismatch |  | 25 |  | 45 | ns |
| $\mathrm{t}_{\text {BLC }}$ | $\overline{\text { BUSY }}$ LOW from $\overline{\mathrm{CE}}$ LOW |  | 25 |  | 45 | ns |
| $\mathrm{t}_{\text {BHC }}$ | $\overline{\text { BUSY }}$ HIGH from $\overline{\mathrm{CE}} \mathrm{HIGH}$ |  | 25 |  | 45 | ns |
| tPS | Port Set-up for Priority | 5 |  | 5 |  | ns |
| ${ }^{\text {t }}$ WB | R/W̄ HIGH after $\overline{\mathrm{BUSY}}$ (Slave) | 0 |  | 0 |  | ns |
| ${ }^{\text {twh }}$ | R/W HIGH after $\overline{\text { BUSY }}$ HIGH (Slave) | 20 |  | 35 |  | ns |
| $\mathrm{t}_{\text {BDD }}{ }^{\text {[39] }}$ | $\overline{\text { BUSY }}$ HIGH to Data Valid |  | 25 |  | 40 | ns |

> CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08

Switching Characteristics for 3.0V Over the Operating Range (continued)

| Parameter | Description | CYDM256A16, <br> CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  | CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | -35 |  | -55 |  |  |
|  |  | Min. | Max. | Min. | Max. |  |
| Interrupt Timing ${ }^{\text {[38] }}$ |  |  |  |  |  |  |
| $\mathrm{t}_{\text {INS }}$ | $\overline{\text { INT Set Time }}$ |  | 31 |  | 45 | ns |
| $\mathrm{t}_{\text {INR }}$ | $\overline{\text { INT Reset Time }}$ |  | 31 |  | 45 | ns |
| Semaphore Timing |  |  |  |  |  |  |
| $\mathrm{t}_{\text {SOP }}$ | SEM Flag Update Pulse ( $\overline{\mathrm{OE}}$ or $\overline{\text { SEM }}$ ) | 10 |  | 15 |  | ns |
| $\mathrm{t}_{\text {SWRD }}$ | SEM Flag Write to Read Time | 10 |  | 10 |  | ns |
| $\mathrm{t}_{\text {SPS }}$ | SEM Flag Contention Window | 10 |  | 10 |  | ns |
| $\mathrm{t}_{\text {SAA }}$ | SEM Address Access Time |  | 35 |  | 55 | ns |

## Switching Waveforms

Read Cycle No. 1 (Either Port Address Access) ${ }^{[40, ~ 41, ~ 42] ~}$


Read Cycle No. 2 (Either Port $\overline{\mathrm{CE}} / \overline{\mathrm{OE}}$ Access) ${ }^{[40,43,44]}$


Notes:
40. R/W is HIGH for read cycles.
41. Device is continuously selected $\overline{\mathrm{CE}}=\mathrm{V}_{\mathrm{IL}}$ and $\overline{\mathrm{UB}}$ or $\overline{\mathrm{LB}}=\mathrm{V}_{\mathrm{IL}}$. This waveform cannot be used for semaphore reads.
42. $\mathrm{OE}=\mathrm{V}_{\mathrm{IL}}$.
43. Address valid prior to or coincident with $\overline{C E}$ transition LOW
44. To access RAM, $\overline{\mathrm{CE}}=\mathrm{V}_{\mathrm{IL}}, \overline{\mathrm{UB}}$ or $\overline{\mathrm{LB}}=\mathrm{V}_{\mathrm{IL}}, \overline{\mathrm{SEM}}=\mathrm{V}_{\mathrm{IH}}$. To access semaphore, $\overline{\mathrm{CE}}=\mathrm{V}_{\mathrm{IH}}, \overline{\mathrm{SEM}}=\mathrm{V}_{\mathrm{IL}}$.

> CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08

## Switching Waveforms (continued)

Read Cycle No. 3 (Either Port) ${ }^{[40, ~ 42, ~ 45, ~ 46] ~}$


Write Cycle No.1: R/W Controlled Timing ${ }^{[45, ~ 46, ~ 47, ~ 48, ~ 49, ~ 50] ~}$


Notes:
45. R/信 must be HIGH during all address transitions.
46. A write occurs during the overlap ( $\mathrm{t}_{\text {SCE }}$ or $\mathrm{t}_{\text {PWE }}$ ) of a LOW $\overline{\mathrm{CE}}$ or $\overline{\mathrm{SEM}}$ and a LOW $\overline{\mathrm{UB}}$ or $\overline{\mathrm{LB}}$.
47. $\mathrm{t}_{\mathrm{HA}}$ is measured from the earlier of CE or R/W or (SEM or R/W) going HIGH at the end of write cycle.
48. If $\overline{O E}$ is LOW during a $R / \bar{W}$ controlled write cycle, the write pulse width must be the larger of $t_{P W E}$ or ( $t_{H Z W E}+t_{S D}$ ) to allow the $I / O$ drivers to turn off and data to be placed on the bus for the required $\mathrm{t}_{\mathrm{SD}}$. If OE is HIGH during an R/W controlled write cycle, this requirement does not apply and the write pulse can be as short as the specified tpWE.
49. To access RAM, CE $=V_{\mathrm{H}}, \overline{\operatorname{SEM}}=\mathrm{V}_{I H}$
50. To access upper byte, $\frac{\mathrm{CE}}{\mathrm{CE}}=\mathrm{V}_{\mathrm{IL}}, \frac{\mathrm{UB}}{\mathrm{LB}}=\mathrm{V}_{\mathrm{IL}}, \frac{\mathrm{SEM}}{\mathrm{SEM}}=\mathrm{V}_{\mathrm{IH}}$.

To access lower byte, $\mathrm{CE}=\mathrm{V}_{\mathrm{IL}}, \mathrm{LB}=\mathrm{V}_{\mathrm{IL}}, \mathrm{SEM}=\mathrm{V}_{\mathrm{IH}}$.
51. Transition is measured $\pm 0 \mathrm{mV}$ from steady state with a $5-\mathrm{pF}$ load (including scope and jig). This parameter is sampled and not $100 \%$ tested. 52. During this period, the I/O pins are in the output state, and input signals must not be applied.

# CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 

## Switching Waveforms (continued)

Write Cycle No. 2: $\overline{\text { CE }}$ Controlled Timing ${ }^{[45, ~ 46, ~ 47, ~ 52] ~}$


Semaphore Read After Write Timing, Either Side ${ }^{[53,54]}$


Notes:
53. If the $\overline{C E}$ or $\overline{S E M}$ LOW transition occurs simultaneously with or after the R/W LOW transition, the outputs remain in the high-impedance state. 54. $\overline{C E}=$ HIGH for the duration of the above timing (both write and read cycle).

## Switching Waveforms (continued)

Timing Diagram of Semaphore Contention ${ }^{[55,56]}$


Timing Diagram of Read with $\overline{\mathrm{BUSY}}(\mathbf{M} / \overline{\mathbf{S}}=\mathbf{H I G H})^{[57]}$


## Notes:

55. $\mathrm{I} / \mathrm{O}_{0 \mathrm{R}}=\mathrm{I} / \mathrm{O}_{0 \mathrm{~L}}=\mathrm{LOW}$ (request semaphore); $\overline{\mathrm{CE}}_{\mathrm{R}}=\overline{\mathrm{CE}}_{\mathrm{L}}=\mathrm{HIGH}$.
56. If $\mathrm{t}_{\mathrm{sPS}}$ is violated, the semaphore will definitely be obtained by one side or the other, but which side will get the semaphore is unpredictable. 57. $\overline{C E}_{\mathrm{L}}=\overline{C E}_{\mathrm{R}}=\mathrm{LOW}$.

## Switching Waveforms (continued)

Write Timing with Busy Input (M/ $\overline{\mathbf{S}}=$ LOW)


Busy Timing Diagram No. 1 ( $\overline{\mathrm{CE}}$ Arbitration)


Note:
58. If $t_{\text {PS }}$ is violated, the busy signal will be asserted on one side or the other, but there is no guarantee to which side $\overline{B U S Y}$ will be asserted.

Switching Waveforms (continued)
Busy Timing Diagram No. 2 (Address Arbitration) ${ }^{[58]}$
Left Address Valid First


## Switching Waveforms (continued)

Interrupt Timing Diagrams


Right Side Sets $\overline{\mathrm{NT}}_{\mathrm{L}}$ :


Left Side Clears $\overline{\text { INT }}_{\mathrm{L}}$ :
ADDRESS $_{\text {R }}$

$\overline{\mathrm{CE}}_{\mathrm{L}}$


Notes:
59. $\mathrm{t}_{\text {HA }}$ depends on which enable pin $\left(\overline{C E}_{L}\right.$ or $\left.R / \bar{W}_{L}\right)$ is deasserted first.
60. $\mathrm{t}_{\text {INS }}$ or $\mathrm{t}_{\text {INR }}$ depends on which enable pin $\left(\overline{C E}_{\mathrm{L}}\right.$ or $\left.\mathrm{R} / \bar{W}_{\mathrm{L}}\right)$ is asserted last.

# CYDM256A16, CYDM128A16, CYDM064A16, CYDM128A08, CYDM064A08 

## Ordering Information

16K x16 1.8V Asynchronous Dual-Port SRAM

| Speed <br> $\mathbf{( n s )}$ | Ordering Code | Package <br> Name | Package Type | Operating <br> Range |
| :---: | :--- | :---: | :--- | :--- |
| 35 | CYDM256A16-35BVXC | BZ100 | 100-Ball Lead Free 0.5-mm Pitch BGA | Commercial |
| 55 | CYDM256A16-55BVXC | BZ100 | 100-Ball Lead Free 0.5-mm Pitch BGA | Commercial |
| 55 | CYDM256A16-55BVXI | BZ100 | 100-Ball Lead Free 0.5-mm Pitch BGA | Industrial |

8K x16 1.8V Asynchronous Dual-Port SRAM

| Speed <br> (ns) | Ordering Code | Package <br> Name | Package Type | Operating <br> Range |
| :---: | :--- | :---: | :--- | :--- |
| 35 | CYDM128A16-35BVXC | BZ100 | 100-Ball Lead Free 0.5-mm Pitch BGA | Commercial |
| 55 | CYDM128A16-55BVXC | BZ100 | 100-Ball Lead Free 0.5-mm Pitch BGA | Commercial |
| 55 | CYDM128A16-55BVXI | BZ100 | 100-Ball Lead Free 0.5-mm Pitch BGA | Industrial |

4K x16 1.8V Asynchronous Dual-Port SRAM

| Speed <br> (ns) | Ordering Code | Package <br> Name | Package Type | Operating <br> Range |
| :---: | :--- | :--- | :--- | :--- |
| 35 | CYDM064A16-35BVXC | BZ100 | 100-Ball Lead Free 0.5-mm Pitch BGA | Commercial |
| 55 | CYDM064A16-55BVXC | BZ100 | 100-Ball Lead Free 0.5-mm Pitch BGA | Commercial |
| 55 | CYDM064A16-55BVXI | BZ100 | 100-Ball Lead Free 0.5-mm Pitch BGA | Industrial |

$16 \mathrm{~K} \times 8$ 1.8V Asynchronous Dual-Port SRAM

| Speed <br> (ns) | Ordering Code | Package <br> Name | Package Type | Operating <br> Range |
| :---: | :--- | :--- | :--- | :--- |
| 35 | CYDM128A08-35BVXC | BZ100 | 100-Ball Lead Free 0.5-mm Pitch BGA | Commercial |
| 55 | CYDM128A08-55BVXC | BZ100 | 100-Ball Lead Free 0.5-mm Pitch BGA | Commercial |
| 55 | CYDM128A08-55BVXI | BZ100 | 100-Ball Lead Free 0.5-mm Pitch BGA | Industrial |

8K x8 1.8V Asynchronous Dual-Port SRAM

| Speed <br> $\mathbf{n s})$ | Ordering Code | Package <br> Name | Package Type | Operating <br> Range |
| :---: | :--- | :--- | :--- | :--- |
| 35 | CYDM064A08-35BVXC | BZ100 | 100-Ball Lead Free 0.5-mm Pitch BGA | Commercial |
| 55 | CYDM064A08-55BVXC | BZ100 | 100-Ball Lead Free 0.5-mm Pitch BGA | Commercial |
| 55 | CYDM064A08-55BVXI | BZ100 | 100-Ball Lead Free 0.5-mm Pitch BGA | Industrial |

Package Diagram
100 VFBGA ( $6 \times 6 \times 1.0 \mathrm{~mm}$ ) BZ100A


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## Document History Page

| Document Title: CYDM064A16/CYDM128A16/CYDM256A16/CYDM064A08/CYDM128A08 1.8V 4K/8K/16K x 16 and 8K/16K x 8 Dual-Port Static RAM <br> Document Number: 38-06081 |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: |
| REV. | ECN NO. | Issue Date | Orig. of Change | Description of Change |
| ** | 272872 | SEE ECN | SPN | New data sheet |
| *A | 300481 | SEE ECN | SPN | Updated $x 8$ pinout, added lead free information, updated part numbers, updated max. supply voltage to ground potential, added package drawing, added open drain output information for ODR, Updated $\mathrm{t}_{\text {BDD }}$, updated package name |
| *B | 333516 | SEE ECN | SPN | Updated $\mathrm{t}_{\text {INS }}, \mathrm{t}_{\text {HZOE }}, \mathrm{t}_{\text {HZCE }}$ Updated note 32 |
| *C | 363174 | SEE ECN | SPN | Added electrical characteristics for 2.5 V and 3.0 V Added timing values for 2.5 V and 3.0 V <br> Updated ISB1 and ISB3 definition <br> Added $\mathrm{I}_{\text {CEX }}$ for all voltages <br> Added $\mathrm{V}_{\text {OL }}$ ODR for all voltages <br> Removed Preliminary |
| *D | 381701 | SEE ECN | YDT | Updated tINS and tINR to 28ns Updated $2.5 \mathrm{~V} / 3.0 \mathrm{~V}$ ICC, ISB1, ISB2, ISB4 Changed 2.5 V VIL to 0.6 V and 3.0 V VIL to 0.7 V (typo) |
| *E | 396697 | SEE ECN | KGH | Updated ISB2 and ISB4 typo to mA. Updated tINS and tINR for -55 to 31 ns . |
| *F | 404588 | SEE ECN | KGH | Updated $\mathrm{I}_{\mathrm{OH}}$ and $\mathrm{I}_{\mathrm{OL}}$ values for the 2.5 V and 3.0 V parameters $\mathrm{V}_{\mathrm{OH}}$ and $\mathrm{V}_{\mathrm{OL}}$ |

